

Data Sheet March 1, 2004 FN7046.1

Ultra-Low Noise, Low Power, Wideband Amplifier



The EL2126 is an ultra-low noise, wideband amplifier that runs on half the supply current of competitive parts.

It is intended for use in systems such as ultrasound imaging where a very small signal needs to be amplified by a large amount without adding significant noise. Its low power dissipation enables it to be packaged in the tiny SOT-23 package, which further helps systems where many input channels create both space and power dissipation problems.

The EL2126 is stable for gains of 10 and greater and uses traditional voltage feedback. This allows the use of reactive elements in the feedback loop, a common requirement for many filter topologies. It operates from $\pm 2.5 \text{V}$ to $\pm 15 \text{V}$ supplies and is available in the 5-pin SOT-23 and 8-pin SO packages.

The EL2126 is fabricated in Elantec's proprietary complementary bipolar process, and is specified for operation over the full -40°C to +85°C temperature range.

Features

- Voltage noise of only 1.3nV/√Hz
- Current noise of only 1.2pA/√Hz
- 200µV offset voltage
- 100MHz -3dB BW for A_V=10
- · Very low supply current 4.7mA
- SOT-23 package
- ±2.5V to ±15V operation

Applications

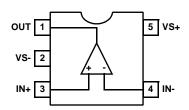
- Ultrasound input amplifiers
- · Wideband instrumentation
- · Communication equipment
- · AGC & PLL active filters
- · Wideband sensors

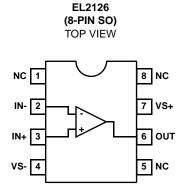
Ordering Information

PART NUMBER	PACKAGE	TAPE & REEL	PKG. DWG. #
EL2126CW-T7	5-Pin SOT-23	7" (3K pcs)	MDP0038
EL2126CW-T7A	5-Pin SOT-23	7" (250 pcs)	MDP0038
EL2126CS	8-Pin SO	-	MDP0027
EL2126CS-T7	8-Pin SO	7"	MDP0027
EL2126CS-T13	8-Pin SO	13"	MDP0027

Pinouts

EL2126 (**5-PIN SOT-23)** TOP VIEW





EL2126

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

IMPORTANT NOTE: All parameters having Min/Max specifications are guaranteed. Typical values are for information purposes only. Unless otherwise noted, all tests are at the specified temperature and are pulsed tests, therefore: $T_J = T_C = T_A$

Electrical Specifications V_S + = +5V, V_S - = -5V, T_A = 25°C, R_F = 180 Ω , R_G = 20 Ω , R_L = 500 Ω unless otherwise specified.

PARAMETER	DESCRIPTION	CONDITIONS	MIN	TYP	MAX	UNIT
DC PERFORM	ANCE		•	•		
Vos	Input Offset Voltage (SO8)			0.2	2	mV
	Input Offset Voltage (SOT23-5)				3	mV
T _{CVOS}	Offset Voltage Temperature Coefficient			17		μV/°C
I _B	Input Bias Current		-10	-7		μA
los	Input Bias Current Offset			0.06	0.6	μA
T _{CIB}	Input Bias Current Temperature Coefficient			0.013		μΑ/°C
C _{IN}	Input Capacitance			2.2		pF
A _{VOL}	Open Loop Gain	V _O = -2.5V to +2.5V	80	87		dB
PSRR	Power Supply Rejection Ratio (Note 1)		80	100		dB
CMRR	Common Mode Rejection Ratio	at CMIR	75	106		dB
CMIR	Common Mode Input Range		-4.6		3.8	V
V _{OUTH}	Positive Output Voltage Swing	No load, $R_F = 1k\Omega$	3.8	3.8		V
V _{OUTL}	Negative Output Voltage Swing	No load, $R_F = 1k\Omega$		-4	-3.9	V
V _{OUTH2}	Positive Output Voltage Swing	$R_L = 100\Omega$	3.2	3.45		V
V _{OUTL2}	Negative Output Voltage Swing	$R_L = 100\Omega$		-3.5	-3.2	V
lout	Output Short Circuit Current (Note 2)		80	100		mA
I _{SY}	Supply Current			4.7	5.5	mA
AC PERFORM	ANCE - $R_G = 20\Omega$, $C_L = 3pF$					
BW	-3dB Bandwidth, $R_L = 500\Omega$			100		MHz
BW ±0.1dB	\pm 0.1dB Bandwidth, R _L = 500Ω			17		MHz
BW ±1dB	\pm 1dB Bandwidth, R _L = 500Ω			80		MHz
Peaking	Peaking, $R_L = 500\Omega$			0.6		dB
SR	Slew Rate	V _{OUT} = 2V _{PP} , measured at 20% to 80%	80	110		V/µs
OS	Overshoot, 4Vpk-pk Output Square	Positive		2.8		%
	Wave	Negative		-7		%
t _S	Settling Time to 0.1% of ±1V Pulse			51		ns
V _N	Voltage Noise Spectral Density			1.3		nV/√Hz
I _N	Current Noise Spectral Density			1.2		pA/√Hz

$\textbf{Electrical Specifications} \qquad \text{V}_{S^+} = +5 \text{V}, \ \text{V}_{S^-} = -5 \text{V}, \ \text{T}_{A} = 25 ^{\circ} \text{C}, \ \text{R}_{F} = 180 \Omega, \ \text{R}_{G} = 20 \Omega, \ \text{R}_{L} = 500 \Omega \ \text{unless otherwise specified}. \ \textbf{(Continued)}$

PARAMETER	DESCRIPTION	CONDITIONS	MIN	TYP	MAX	UNIT
HD2	2nd Harmonic Distortion (Note 3)			-70		dBc
HD3	3rd Harmonic Distortion (Note 3)			-70		dBc

NOTES:

- 1. Measured by moving the supplies from ±4V to ±6V
- 2. Pulse test only and using a 10Ω load
- 3. Frequency = 1MHz, V_{OUT} = 2Vpk-pk, into 500 Ω and 5pF load

$\textbf{Electrical Specifications} \qquad \text{V}_{S^+} = +15 \text{V}, \ \text{V}_{S^-} = -15 \text{V}, \ \text{T}_{A} = 25 ^{\circ}\text{C}, \ \text{R}_{F} = 180 \Omega, \ \text{R}_{G} = 20 \Omega, \ \text{R}_{L} = 500 \Omega \ \text{unless otherwise specified}.$

PARAMETER	DESCRIPTION	CONDITIONS	MIN	TYP	MAX	UNIT
DC PERFORMA	ANCE		U	1	l.	
Vos	Input Offset Voltage (SO8)			0.5	3	mV
	Input Offset Voltage (SOT23-5)				3	mV
T _{CVOS}	Offset Voltage Temperature Coefficient			4.5		μV/°C
I _B	Input Bias Current		-10	-7		μA
Ios	Input Bias Current Offset			0.12	0.7	μA
T _{CIB}	Input Bias Current Temperature Coefficient			0.016		μΑ/°C
C _{IN}	Input Capacitance			2.2		pF
A _{VOL}	Open Loop Gain		80	90		dB
PSRR	Power Supply Rejection Ratio (Note 1)		65	80		dB
CMRR	Common Mode Rejection Ratio	at CMIR	70	85		dB
CMIR	Common Mode Input Range		-14.6		13.8	V
V _{OUTH}	Positive Output Voltage Swing	No load, $R_F = 1k\Omega$	13.6	13.7		V
V _{OUTL}	Negative Output Voltage Swing	No load, $R_F = 1k\Omega$		-13.8	-13.7	V
V _{OUTH2}	Positive Output Voltage Swing	$R_L = 100\Omega$, $R_F = 1k\Omega$	10.2	11.2		V
V _{OUTL2}	Negative Output Voltage Swing	$R_L = 100\Omega$, $R_F = 1k\Omega$		-10.3	-9.5	V
lout	Output Short Circuit Current (Note 2)		140	220		mA
I _{SY}	Supply Current			5	6	mA
AC PERFORMA	ANCE - $R_G = 20\Omega$, $C_L = 3pF$		<u> </u>			
BW	-3dB Bandwidth, $R_L = 500\Omega$			135		MHz
BW ±0.1dB	\pm 0.1dB Bandwidth, R _L = 500Ω			26		MHz
BW ±1dB	±1dB Bandwidth, $R_L = 500\Omega$			60		MHz
Peaking	Peaking, $R_L = 500\Omega$			2.1		dB
SR	Slew Rate (±2.5V Square Wave, Measured 25%-75%)		130	150		V/µS
OS	Overshoot, 4Vpk-pk Output Square	Positive		1.6		%
	Wave	Negative		-4.4		%
T _S	Settling Time to 0.1% of ±1V Pulse			48		ns
V _N	Voltage Noise Spectral Density			1.4		nV/√Hz

EL2126

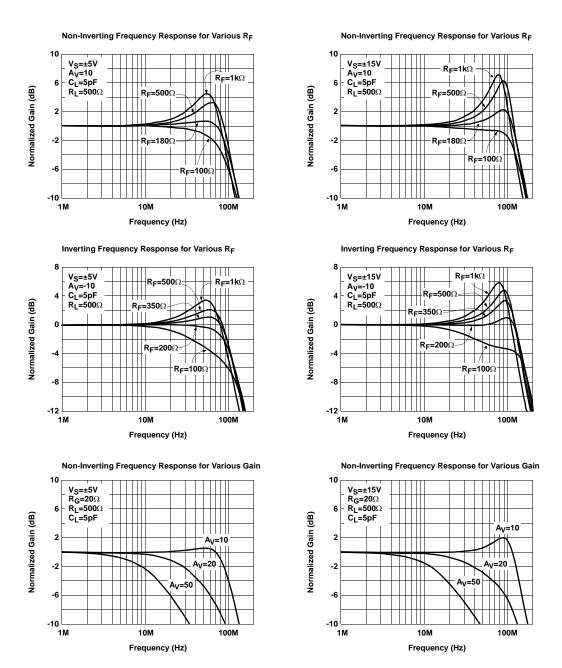
 $\textbf{Electrical Specifications} \qquad \text{V_S+ = +15V$, V_S- = -15V$, T_A = $25^{\circ}C$, R_F = 180Ω, R_G = 20Ω, R_L = 500Ω unless otherwise specified. (Continued)}$

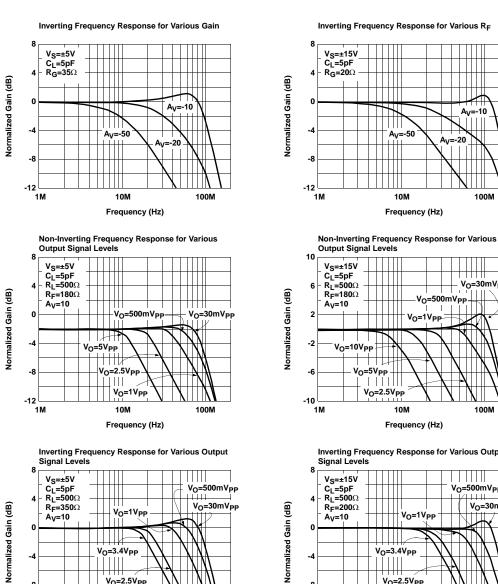
PARAMETER	DESCRIPTION CONDITIONS		MIN	TYP	MAX	UNIT
I _N	Current Noise Spectral Density			1.1		pA/√Hz
HD2	2nd Harmonic Distortion (Note 3)	d Harmonic Distortion (Note 3)		-72		dBc
HD3	3rd Harmonic Distortion (Note 3)			-73		dBc

NOTES:

- 1. Measured by moving the supplies from $\pm 13.5 \text{V}$ to $\pm 16.5 \text{V}$
- 2. Pulse test only and using a $10\Omega\mbox{ load}$
- 3. Frequency = 1MHz, V_{OUT} = 2Vpk-pk, into 500Ω and 5pF load

Typical Performance Curves





Frequency (Hz)

A_V=-10

100M

 $V_O=30mV_{PP}$

100M

V_O=500mV_{PP}

 $V_{O}=1V_{PP}$

Frequency (Hz)

A_V=-50

10M

Frequency (Hz)

 $V_O=1V_{PP}$

V_O=2.5V_{PP}

10M

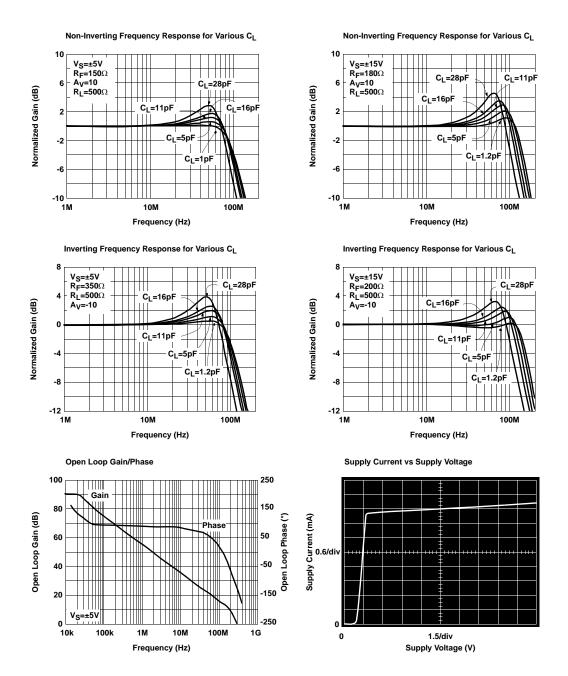
Frequency (Hz)

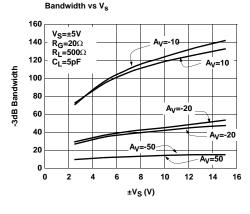
100M

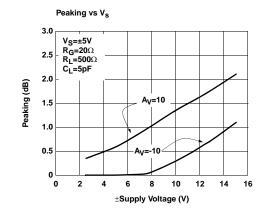
A_V=10

-12

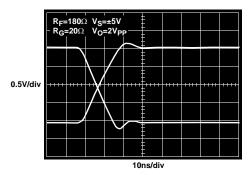
1M

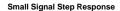


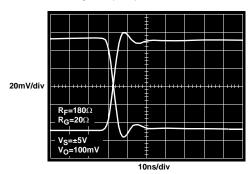




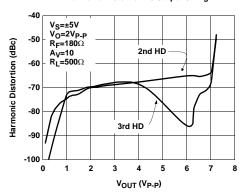




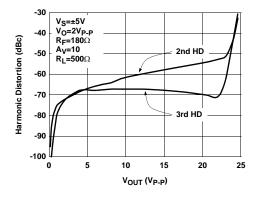


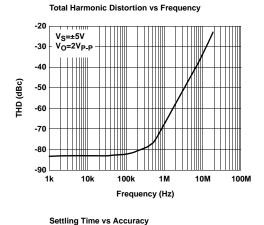


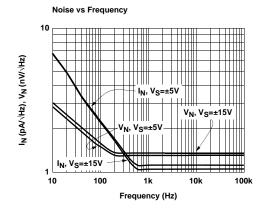
1MHz Harmonic Distortion vs Output Swing

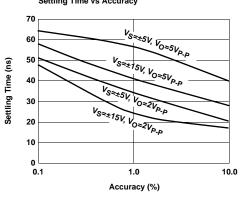


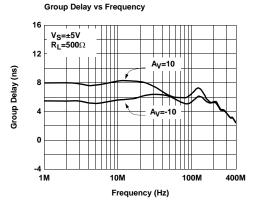
1MHz Harmonic Distortion vs Output Swing

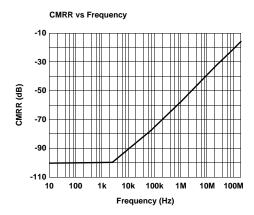


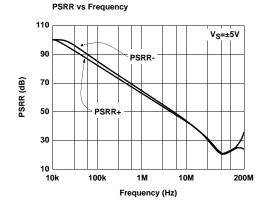


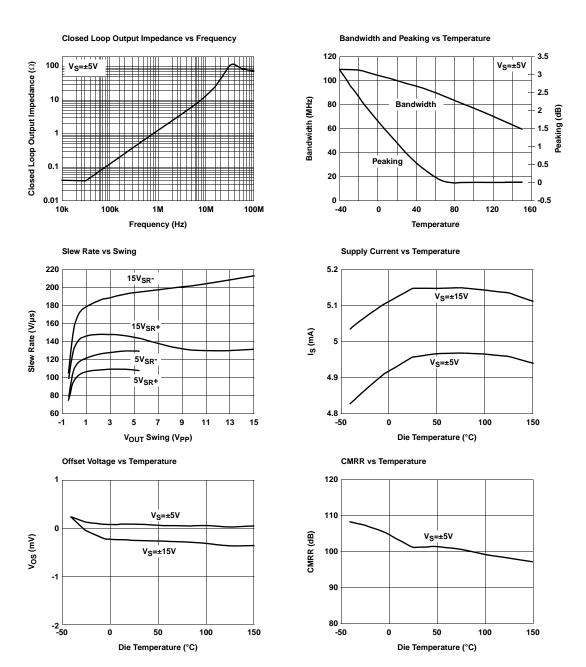


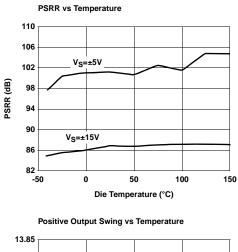


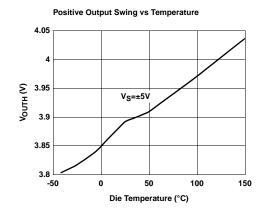


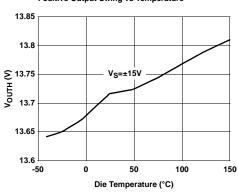


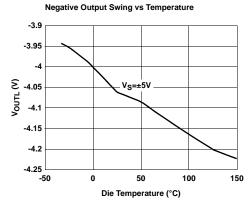


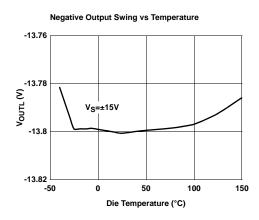


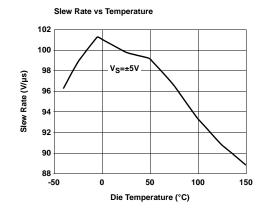


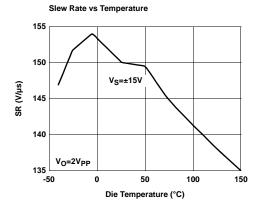


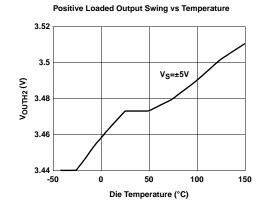


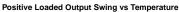


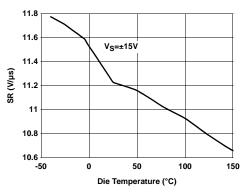




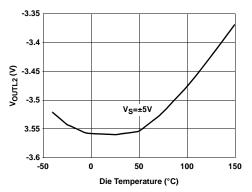




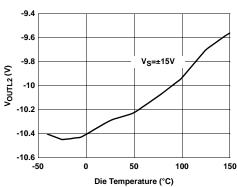




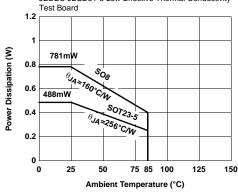
Negative Loaded Output Swing vs Temperature



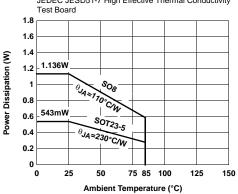
Negative Loaded Output Swing vs Temperature



Package Power Dissipation vs Ambient Temperature JEDEC JESD51-3 Low Effective Thermal Conductivity



Package Power Dissipation vs Ambient Temperature JEDEC JESD51-7 High Effective Thermal Conductivity



Pin Descriptions

= 0001.16				
EL2126CW (5-PIN SOT-23)	EL2126CS (8-PIN SO)	PIN NAME	PIN FUNCTION	EQUIVALENT CIRCUIT
1	6	VOUT	Output	V _S + V _{OUT} Circuit 1
2	4	VS-	Supply	
3	3	VINA+	Input	V _{IN} + • V _{IN} - Circuit 2
4	2	VINA-	Input	Reference Circuit 2
5	7	VS+	Supply	

Applications Information

Product Description

The EL2126 is an ultra-low noise, wideband monolithic operational amplifier built on Elantec's proprietary high speed complementary bipolar process. It features 1.3nV/ $\sqrt{\text{Hz}}$ input voltage noise, 200 μ V typical offset voltage, and 73dB THD. It is intended for use in systems such as ultrasound imaging where very small signals are needed to be amplified. The EL2126 also has excellent DC specifications: 200 μ V VOS, 22 μ A IB, 0.4 μ A IOS, and 106dB CMRR. These specifications allow the EL2126 to be used in DC-sensitive applications such as difference amplifiers.

Gain-Bandwidth Product

The EL2126 has a gain-bandwidth product of 650MHz at \pm 5V. For gains less than 20, higher-order poles in the amplifier's transfer function contribute to even higher closed-loop bandwidths. For example, the EL2126 has a -3dB bandwidth of 100MHz at a gain of 10 and decreases to 33MHz at gain of 20. It is important to note that the extra bandwidth at lower gain does not come at the expenses of stability. Even though the EL2126 is designed for gain \geq 10. With external compensation, the device can also operate at lower gain settings. The RC network shown in Figure 1 reduces the feedback gain at high frequency and thus maintains the amplifier stability. R values must be less than RF divided by 9 and 1 divided by 2π RC must be less than 200MHz.

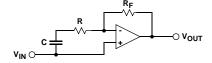


FIGURE 1.

Choice of Feedback Resistor, RF

The feedback resistor forms a pole with the input capacitance. As this pole becomes larger, phase margin is reduced. This increases ringing in the time domain and peaking in the frequency domain. Therefore, RF has some maximum value which should not be exceeded for optimum performance. If a large value of RF must be used, a small capacitor in the few pF range in parallel with RF can help to reduce this ringing and peaking at the expense of reducing the bandwidth. Frequency response curves for various RF values are shown in the typical performance curves section of this data sheet.

Noise Calculations

The primary application for the EL2126 is to amplify very small signals. To maintain the proper signal-to-noise ratio, it is essential to minimize noise contribution from the amplifier. Figure 2 below shows all the noise sources for all the components around the amplifier.

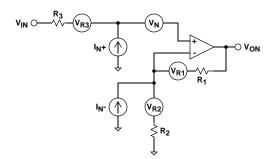


FIGURE 2.

 V_N is the amplifier input voltage noise I_{N^+} is the amplifier positive input current noise I_{N^-} is the amplifier negative input current noise V_{RX} is the thermal noise associated with each resistor:

$$V_{RX} = \sqrt{4kTRx}$$

where:

k is Boltzmann's constant = 1.380658×10^{-23}

T is temperature in degrees Kelvin (273+ °C)

The total noise due to the amplifier seen at the output of the amplifier can be calculated by using the following equation (Figure 3).

As the equation shows, to keep noise at a minimum, small resistor values should be used. At higher amplifier gain configuration where R_2 is reduced, the noise due to IN-, R_2 , and R_1 decreases and the noise caused by IN+, VN, and R_3 starts to dominate. Because noise is summed in a root-mean-squares method, noise sources smaller than 25% of the largest noise source can be ignored. This can greatly simplify the formula and make noise calculation much easier to calculate.

Output Drive Capability

The EL2126 is designed to drive low impedance load. It can easily drive $6V_{P-P}$ signal into a 100Ω load. This high output drive capability makes the EL2126 an ideal choice for RF, IF,

$$V_{ON} = \sqrt{BW} \times \sqrt{\left(VN^2 \times \left(1 + \frac{R_1}{R_2}\right)^2 + IN^{-2} \times R_1^{\ 2} + IN^{+2} \times R_3^{\ 2} \times \left(1 + \frac{R_1}{R_2}\right)^2 + 4 \times K \times T \times R_1 + 4 \times K \times T \times R_2 \times \left(\frac{R_1}{R_2}\right)^2 + 4 \times K \times T \times R_3 \times \left(1 + \frac{R_1}{R_2}\right)^2\right)}$$

FIGURE 3.

and video applications. Furthermore, the EL2126 is currentlimited at the output, allowing it to withstand momentary short to ground. However, the power dissipation with outputshorted cannot exceed the power dissipation capability of the package.

Driving Cables and Capacitive Loads

Although the EL2126 is designed to drive low impedance load, capacitive loads will decreases the amplifier's phase margin. As shown in the performance curves, capacitive load can result in peaking, overshoot and possible oscillation. For optimum AC performance, capacitive loads should be reduced as much as possible or isolated with a series resistor between 5Ω to 20Ω . When driving coaxial cables, double termination is always recommended for reflection-free performance. When properly terminated, the capacitance of the coaxial cable will not add to the capacitive load seen by the amplifier.

Power Supply Bypassing And Printed Circuit Board Layout

As with any high frequency devices, good printed circuit board layout is essential for optimum performance. Ground plane construction is highly recommended. Lead lengths should be kept as short as possible. The power supply pins must be closely bypassed to reduce the risk of oscillation. The combination of a 4.7 μ F tantalum capacitor in parallel with 0.1 μ F ceramic capacitor has been proven to work well when placed at each supply pin. For single supply operation,

where pin 4 (V_S -) is connected to the ground plane, a single 4.7 μ F tantalum capacitor in parallel with a 0.1 μ F ceramic capacitor across pins 7 (V_S +) and pin 4 (V_S -) will suffice.

For good AC performance, parasitic capacitance should be kept to a minimum. Ground plane construction again should be used. Small chip resistors are recommended to minimize series inductance. Use of sockets should be avoided since they add parasitic inductance and capacitance which will result in additional peaking and overshoot.

Supply Voltage Range and Single Supply Operation

The EL2126 has been designed to operate with supply voltage range of ± 2.5 V to ± 15 V. With a single supply, the EL2126 will operate from +5V to +30V. Pins 4 and 7 are the power supply pins. The positive power supply is connected to pin 7. When used in single supply mode, pin 4 is connected to ground. When used in dual supply mode, the negative power supply is connected to pin 4.

As the power supply voltage decreases from +30V to +5V, it becomes necessary to pay special attention to the input voltage range. The EL2126 has an input voltage range of 0.4V from the negative supply to 1.2V from the positive supply. So, for example, on a single +5V supply, the EL2126 has an input voltage range which spans from 0.4V to 3.8V. The output range of the EL2126 is also quite large, on a +5V supply, it swings from 0.4V to 3.8V.

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